

<b>Notice of References Cited</b>	Application/Control No. 10/003,695	Applicant(s)/Patent Under Reexamination TOYAMA, HIROSHI	
	Examiner Mark A. Chapman	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0110746	08-2002	Oshiba et al.	430/108.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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